**Product data sheet** 

## 1. Product profile

#### 1.1 General description

The BF1207 is a combination of two dual gate MOSFET amplifiers with shared source and gate2 leads and an integrated switch.

The source and substrate are interconnected. Internal bias circuits enable Direct Current (DC) stabilization and a very good cross-modulation performance during Automatic Gain Control (AGC). Integrated diodes between the gates and source protect against excessive input voltage surges. The BF1207 has a SOT363 micro-miniature plastic package.

#### **CAUTION**



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

#### 1.2 Features and benefits

- Two low noise gain controlled amplifiers in a single package. One with a fully integrated bias and one with partly integrated bias
- Internal switch to save external components
- Superior cross-modulation performance during AGC
- High forward transfer admittance
- High forward transfer admittance to input capacitance ratio

#### 1.3 Applications

 Gain controlled low noise amplifiers for Very High Frequency (VHF) and Ultra High Frequency (UHF) applications with 5 V supply voltage, such as digital and analog television tuners and professional communication equipment



#### **Dual N-channel dual gate MOSFET**

#### 1.4 Quick reference data

**Table 1. Quick reference data**Per MOSFET unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	DC		-	-	6	V
$I_D$	drain current	DC		-	-	30	mA
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> ≤ 107 °C	<u>[1]</u>	-	-	180	mW
y <sub>fs</sub>	forward transfer admittance	f = 1 MHz					
		amplifier A; I <sub>D</sub> = 18 mA		25	30	40	mS
		amplifier B; I <sub>D</sub> = 14 mA		26	31	41	mS
C <sub>iss(G1)</sub>	input capacitance at gate1	f = 100 MHz					
		amplifier A		-	2.2	2.7	pF
		amplifier B		-	1.9	2.4	pF
C <sub>rss</sub>	reverse transfer capacitance	f = 100 MHz		-	20	-	fF
NF	noise figure	amplifier A; f = 400 MHz		-	1.3	-	dB
		amplifier B; f = 800 MHz		-	1.4	-	dB
Xmod	cross-modulation	input level for k = 1 % at 40 dB AGC					
		amplifier A		100	105	-	$dB\mu V$
		amplifier B		100	103	-	$dB\mu V$
Tj	junction temperature			-	-	150	°C

<sup>[1]</sup>  $T_{sp}$  is the temperature at the soldering point of the source lead.

# 2. Pinning information

Table 2. Discrete pinning

10010 21	Discrete pinning		
Pin	Description	Simplified outline	Symbol
1	drain (AMP A)		
2	source	□6 □5 □4	AMP B
3	drain (AMP B)		G1B DB
4	gate1 (AMP B)	0	
5	gate2	1 2 3	G2 H
6	gate1 (AMP A)		G1A Sym108

#### **Dual N-channel dual gate MOSFET**

# 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BF1207	-	plastic surface mounted package; 6 leads	SOT363

# 4. Marking

Table 4. Marking

Type number	Marking code[1]
BF1207	M2*

<sup>[1] \* =</sup> p: Made in Hong Kong.

# 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

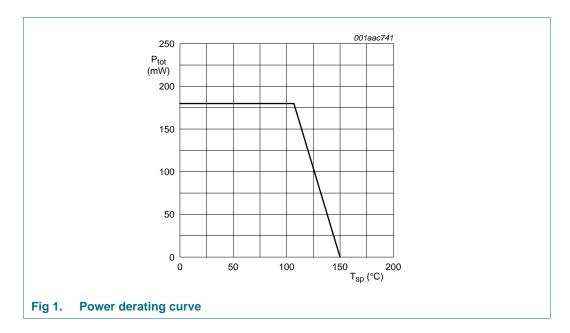
Symbol	Parameter	Conditions	Min	Max	Unit
Per MOSF	ET				
$V_{DS}$	drain-source voltage	DC	-	6	V
$I_D$	drain current	DC	-	30	mA
I <sub>G1</sub>	gate1 current		-	±10	mA
$I_{G2}$	gate2 current		-	±10	mA
P <sub>tot</sub>	total power dissipation	$T_{sp} \le 107  ^{\circ}C$	[1] -	180	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-	150	°C

<sup>[1]</sup>  $T_{sp}$  is the temperature at the soldering point of the source lead.

<sup>\* =</sup> t: Made in Malaysia.

<sup>\* =</sup> W: Made in China.

#### **Dual N-channel dual gate MOSFET**



# 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to soldering point		240	K/W

# 7. Static characteristics

Table 7. Static characteristics

 $T_j = 25 \, ^{\circ}\text{C}$ .

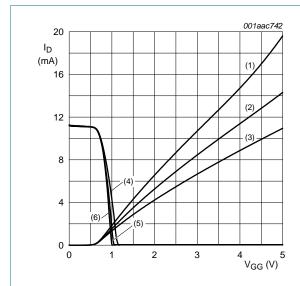
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per MOSFE	T; unless otherwise specified					
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0 \text{ V}; I_D = 10 \mu\text{A}$				
		amplifier A	6	-	-	V
		amplifier B	6	-	-	V
V <sub>(BR)G1-SS</sub>	gate1-source breakdown voltage	$V_{GS} = V_{DS} = 0 \text{ V}; I_{G1-S} = 10 \text{ mA}$	6	-	10	V
V <sub>(BR)G2-SS</sub>	gate2-source breakdown voltage	$V_{GS} = V_{DS} = 0 \text{ V}; I_{G2-S} = 10 \text{ mA}$	6	-	10	V
V <sub>F(S-G1)</sub>	forward source-gate1 voltage	$V_{G2-S} = V_{DS} = 0 \text{ V}; I_{S-G1} = 10 \text{ mA}$	0.5	-	1.5	V
V <sub>F(S-G2)</sub>	forward source-gate2 voltage	$V_{G1-S} = V_{DS} = 0 \text{ V}; I_{S-G2} = 10 \text{ mA}$	0.5	-	1.5	V
V <sub>G1-S(th)</sub>	gate1-source threshold voltage	$V_{DS} = 5 \text{ V}; V_{G2-S} = 4 \text{ V}; I_D = 100 \mu\text{A}$	0.3	-	1.0	V
V <sub>G2-S(th)</sub>	gate2-source threshold voltage	$V_{DS} = 5 \text{ V}; V_{G1-S} = 5 \text{ V}; I_D = 100 \mu\text{A}$	0.4	-	1.0	V
I <sub>DSX</sub>	drain-source current	$V_{G2-S}$ = 4 V; $V_{DS}$ = 5 V; $R_{G1}$ = 68 k $\Omega$				
		amplifier A	<u>[1]</u> 13	-	23	mΑ
		amplifier B	<u>[2]</u> 9	-	19	mA

## **Dual N-channel dual gate MOSFET**

**Table 7.** Static characteristics ...continued  $T_i = 25$  °C.

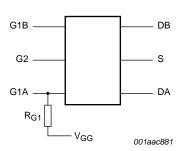
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>G1-S</sub>	gate1 cut-off current	$V_{G2-S} = V_{DS(A)} = 0 V$				
		amplifier A; $V_{G1-S(A)} = 5 \text{ V}$ ; $V_{DS(B)} = 0 \text{ V}$	-	-	50	nΑ
		amplifier B; $V_{G1-S(A)} = 0 \text{ V}$ ; $I_{D(B)} = 0 \text{ A}$	-	-	50	nA
I <sub>G2-S</sub>	gate2 cut-off current	$V_{G2-S} = 4 \text{ V}; V_{G1-S} = V_{DS(A)} = V_{DS(B)} = 0 \text{ V};$	-	-	20	nA

- [1]  $R_{G1}$  connects gate1 (A) to  $V_{GG} = 5 \text{ V}$  (see Figure 3).
- [2]  $R_{G1}$  connects gate1 (B) to  $V_{GG} = 0 \text{ V}$  (see Figure 3).



- (1)  $I_{D(A)}$ ;  $R_{G1} = 47 \text{ k}\Omega$ .
- (2)  $I_{D(A)}$ ;  $R_{G1} = 68 \text{ k}\Omega$ .
- (3)  $I_{D(A)}$ ;  $R_{G1} = 100 \text{ k}\Omega$ .
- (4)  $I_{D(B)}$ ;  $R_{G1} = 100 \text{ k}\Omega$ .
- (5)  $I_{D(B)}$ ;  $R_{G1} = 68 \text{ k}\Omega$ .
- (6)  $I_{D(B)}; R_{G1} = 47 \text{ k}\Omega.$   $V_{DS(A)} = V_{DS(B)} = 5 \text{ V}; V_{G2\text{-}S} = 4 \text{ V}; T_j = 25 \text{ °C}.$

Fig 2. Drain currents of MOSFET A and B as function of  $\ensuremath{\text{V}_{\text{GG}}}$ 



 $V_{GG}$  = 5 V: amplifier A is on; amplifier B is off.  $V_{GG}$  = 0 V: amplifier A is off; amplifier B is on.

Fig 3. Functional diagram

#### **Dual N-channel dual gate MOSFET**

# 8. Dynamic characteristics

## 8.1 Dynamic characteristics for amplifier A

Table 8. Dynamic characteristics for amplifier A

Common source;  $T_{amb} = 25$  °C;  $V_{G2-S} = 4$  V;  $V_{DS} = 5$  V;  $I_D = 18$  mA.[1]

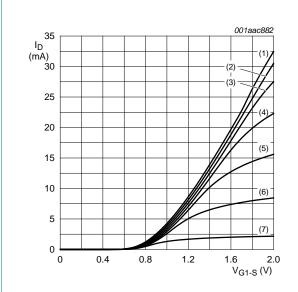
Symbol	Parameter	Conditions	M	lin	Тур	Max	Unit
$ y_{fs} $	forward transfer admittance	$T_j = 25  ^{\circ}C$	2	5	30	40	mS
C <sub>iss(G1)</sub>	input capacitance at gate1	f = 100 MHz	-		2.2	2.7	pF
C <sub>iss(G2)</sub>	input capacitance at gate2	f = 1 MHz	-		3.5	-	pF
Coss	output capacitance	f = 100 MHz	-		0.9	-	pF
$C_{rss}$	reverse transfer capacitance	f = 100 MHz	-		20	-	fF
G <sub>tr</sub>	power gain	$B_S = B_{S(opt)};  B_L = B_{L(opt)}$					
		$f = 200 \text{ MHz}; G_S = 2 \text{ mS}; G_L = 0.5 \text{ mS}$	30	0	34	38	dB
		$f = 400 \text{ MHz}; G_S = 2 \text{ mS}; G_L = 1 \text{ mS}$	20	6	30	34	dB
		$f = 800 \text{ MHz}; G_S = 3.3 \text{ mS}; G_L = 1 \text{ mS}$	2	1	25	29	dB
NF	noise figure	$f = 11 \text{ MHz}; G_S = 20 \text{ mS}; B_S = 0 \text{ S}$	-		3.0	-	dB
		$f = 400 \text{ MHz}; Y_S = Y_{S(opt)}$	-		1.3	-	dB
		$f = 800 \text{ MHz}; Y_S = Y_{S(opt)}$	-		1.4	-	dB
Xmod	cross-modulation	input level for $k = 1 \%$ ; $f_w = 50 MHz$ ; $f_{unw} = 60 MHz$	[2]				
		at 0 dB AGC	90	)	-	-	$dB\mu V$
		at 10 dB AGC	-		90	-	$dB\mu V$
		at 20 dB AGC	-		99	-	$dB\mu V$
		at 40 dB AGC	10	00	105	-	$dB\mu V$

<sup>[1]</sup> For the MOSFET not in use:  $V_{G1-S(B)} = 0 \text{ V}$ ;  $V_{DS(B)} = 0 \text{ V}$ .

<sup>[2]</sup> Measured in Figure 29 test circuit.

#### **Dual N-channel dual gate MOSFET**

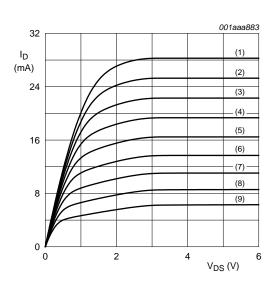
#### 8.1.1 Graphs for amplifier A



- (1)  $V_{G2-S} = 4 \text{ V}.$
- (2)  $V_{G2-S} = 3.5 \text{ V}.$
- (3)  $V_{G2-S} = 3 \text{ V}$ .
- (4)  $V_{G2-S} = 2.5 \text{ V}.$
- (5)  $V_{G2-S} = 2 V$ .
- (6)  $V_{G2-S} = 1.5 \text{ V}.$
- (7)  $V_{G2-S} = 1 \text{ V}.$

$$V_{DS(A)} = 5 \text{ V}; T_j = 25 \text{ }^{\circ}\text{C}.$$

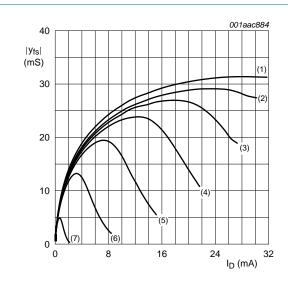
Fig 4. Amplifier A: transfer characteristics; typical values



- (1)  $V_{G1-S(A)} = 1.9 \text{ V}.$
- (2)  $V_{G1-S(A)} = 1.8 \text{ V}.$
- (3)  $V_{G1-S(A)} = 1.7 \text{ V}.$
- (4)  $V_{G1-S(A)} = 1.6 \text{ V}.$
- (5)  $V_{G1-S(A)} = 1.5 \text{ V}.$
- (6)  $V_{G1-S(A)} = 1.4 \text{ V}.$
- (7)  $V_{G1-S(A)} = 1.3 \text{ V}.$
- (8)  $V_{G1-S(A)} = 1.2 \text{ V}.$ (9)  $V_{G1-S(A)} = 1.1 \text{ V}.$ 
  - $V_{DS(A)} = 5 \text{ V}; V_{G2-S} = 4 \text{ V}; T_j = 25 \text{ °C}.$

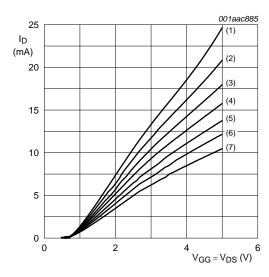
Fig 5. Amplifier A: output characteristics; typical values

#### **Dual N-channel dual gate MOSFET**



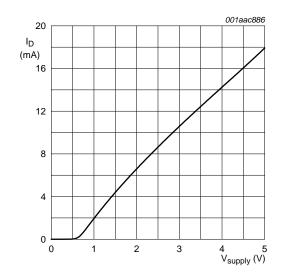
- (1)  $V_{G2-S} = 4 \text{ V}$ .
- (2)  $V_{G2-S} = 3.5 \text{ V}.$
- (3)  $V_{G2-S} = 3 \text{ V}.$
- (4)  $V_{G2-S} = 2.5 \text{ V}.$
- (5)  $V_{G2-S} = 2 V$ .
- (6)  $V_{G2-S} = 1.5 \text{ V}.$
- (7)  $V_{G2-S} = 1 \text{ V}.$  $V_{DS(A)} = 5 \text{ V}; T_j = 25 \text{ }^{\circ}\text{C}.$

Fig 6. Amplifier A: forward transfer admittance as a function of drain current; typical values



- (1)  $R_{G1(A)} = 39 \text{ k}\Omega$ .
- (2)  $R_{G1(A)} = 47 \text{ k}\Omega$ .
- (3)  $R_{G1(A)} = 68 \text{ k}\Omega$ .
- (4)  $R_{G1(A)} = 82 \text{ k}\Omega$ .
- (5)  $R_{G1(A)} = 100 \text{ k}\Omega$ .
- (6)  $R_{G1(A)} = 120 \text{ k}\Omega$ .
- (7)  $R_{G1(A)} = 150 \text{ k}\Omega$ .
  - $V_{G2-S} = 4 \text{ V}; T_j = 25 \,^{\circ}\text{C}.$

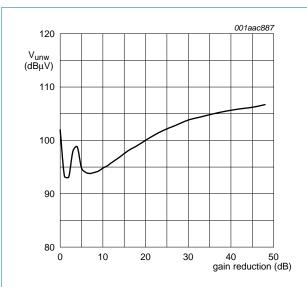
Fig 7. Amplifier A: drain current as a function of  $V_{DS}$  and  $V_{GG}$ ; typical values



 $V_{G2-S}$  = 4 V,  $T_j$  = 25 °C,  $R_{G1(B)}$  = 68 k $\Omega$  (connected to ground); see Figure 3.

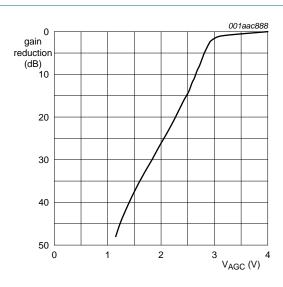
Fig 8. Amplifier A: drain current of amplifier A as a function of supply voltage of A and B amplifier; typical values

#### **Dual N-channel dual gate MOSFET**



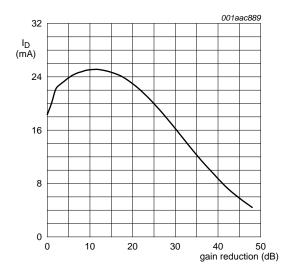
$$\begin{split} V_{DS(A)} = V_{DS(B)} = 5 \text{ V; } V_{G1\text{-}S(B)} = 0 \text{ V; } f_w = 50 \text{ MHz;} \\ f_{unw} = 60 \text{ MHz; } T_{amb} = 25 \text{ °C; see } \frac{\text{Figure 29}}{\text{MHz}}. \end{split}$$

Fig 9. Amplifier A: unwanted voltage for 1 % cross-modulation as a function of gain reduction; typical values



 $V_{DS(A)} = V_{DS(B)} = 5$  V;  $V_{G1-S(B)} = 0$  V; f = 50 MHz; see Figure 29.

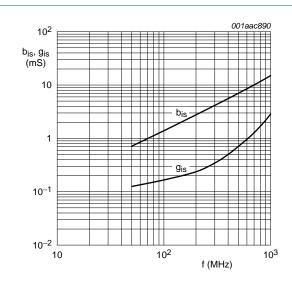
Fig 10. Amplifier A: gain reduction as a function of AGC voltage; typical values



 $V_{DS(A)} = V_{DS(B)} = 5 \text{ V}; V_{G1-S(B)} = 0 \text{ V}; f = 50 \text{ MHz}; T_{amb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 29}}{\text{Figure 29}}.$ 

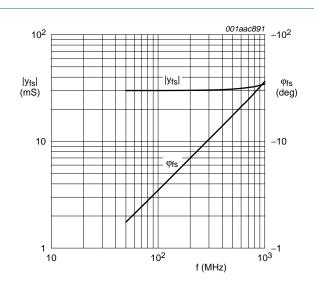
Fig 11. Amplifier A: drain current as a function of gain reduction; typical values

#### **Dual N-channel dual gate MOSFET**



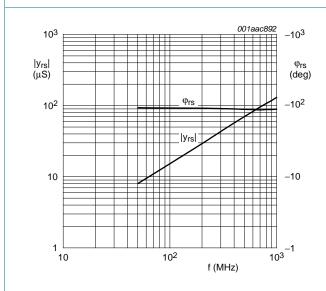
 $V_{DS(A)}=5$  V;  $V_{G2\text{-}S}=4$  V;  $V_{DS(B)}=V_{G1\text{-}S(B)}=0$  V;  $I_{D(A)}=18$  mA.

Fig 12. Amplifier A: input admittance as a function of frequency; typical values



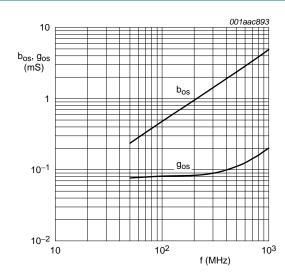
 $V_{DS(A)} = 5$  V;  $V_{G2-S} = 4$  V;  $V_{DS(B)} = V_{G1-S(B)} = 0$  V;  $I_{D(A)} = 18$  mA.

Fig 13. Amplifier A: forward transfer admittance and phase as a function of frequency; typical values



 $V_{DS(A)} = 5 \text{ V}; V_{G2-S} = 4 \text{ V}; V_{DS(B)} = V_{G1-S(B)} = 0 \text{ V}; I_{D(A)} = 18 \text{ mA}.$ 

Fig 14. Amplifier A: reverse transfer admittance and phase as a function of frequency: typical values



 $V_{DS(A)}$  = 5 V;  $V_{G2\text{-}S}$  = 4 V;  $V_{DS(B)}$  =  $V_{G1\text{-}S(B)}$  = 0 V;  $I_{D(A)}$  = 18 mA.

Fig 15. Amplifier A: output admittance as a function of frequency; typical values

#### **Dual N-channel dual gate MOSFET**

## 8.1.2 Scattering parameters for amplifier A

Table 9. Scattering parameters for amplifier A

 $V_{DS(A)} = 5 \text{ V; } V_{G2-S} = 4 \text{ V; } I_{D(A)} = 18 \text{ mA; } V_{DS(B)} = 0 \text{ V; } V_{G1-S(B)} = 0 \text{ V; } T_{amb} = 25 \text{ °C; typical values.}$ 

f	s <sub>11</sub>		S <sub>21</sub>		s <sub>12</sub>		S <sub>22</sub>	
(MHz)	Magnitude (ratio)	Angle (deg)						
50	0.987	-4.169	2.87	175.5	0.0008	83.82	0.992	-1.42
100	0.983	-8.109	2.95	171.14	0.0015	82.08	0.992	-2.86
200	0.976	-15.97	2.93	162.44	0.0028	77.50	0.990	-5.66
300	0.966	-23.844	2.89	153.77	0.0041	73.45	0.989	-8.49
400	0.952	-31.575	2.84	145.23	0.0053	69.42	0.986	-11.28
500	0.935	-35.225	2.78	136.82	0.0063	65.72	0.984	-14.03
600	0.917	-46.678	2.72	128.50	0.0072	61.48	0.981	-16.80
700	0.898	-54.094	2.65	120.44	0.0079	58.05	0.977	-19.55
800	0.876	-61.205	2.57	112.33	0.0084	52.74	0.974	-22.32
900	0.852	-68.299	2.49	104.32	0.0089	48.61	0.970	-25.10
1000	0.826	-75.321	2.41	96.42	0.0091	43.86	0.967	-27.88

#### **Dual N-channel dual gate MOSFET**

# 8.2 Dynamic characteristics for amplifier B

Table 10. Dynamic characteristics for amplifier B

Common source;  $T_{amb}$  = 25 °C;  $V_{G2-S}$  = 4 V;  $V_{DS}$  = 5 V;  $I_D$  = 14 mA.[1]

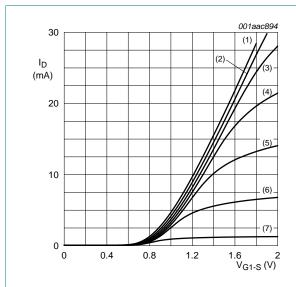
Symbol	Parameter	Conditions	М	in	Тур	Max	Unit
$ y_{fs} $	forward transfer admittance	T <sub>j</sub> = 25 °C	26	3	31	41	mS
C <sub>iss(G1)</sub>	input capacitance at gate1	f = 100 MHz	-		1.8	2.3	pF
C <sub>iss(G2)</sub>	input capacitance at gate2	f = 1 MHz	-		3.5	-	pF
C <sub>oss</sub>	output capacitance	f = 100 MHz	-		8.0	-	pF
$C_{rss}$	reverse transfer capacitance	f = 100 MHz	-		20	-	fF
G <sub>tr</sub>	power gain	$B_S = B_{S(opt)};  B_L = B_{L(opt)}$					
		$f = 200 \text{ MHz}; G_S = 2 \text{ mS}; G_L = 0.5 \text{ mS}$	30	)	34	38	dB
		$f = 400 \text{ MHz}; G_S = 2 \text{ mS}; G_L = 1 \text{ mS}$	27	7	31	35	dB
		$f = 800 \text{ MHz}; G_S = 3.3 \text{ mS}; G_L = 1 \text{ mS}$	23	3	27	31	dB
NF	noise figure	$f = 11 \text{ MHz}; G_S = 20 \text{ mS}; B_S = 0 \text{ S}$	-		5	-	dB
		$f = 400 \text{ MHz}; Y_S = Y_{S(opt)}$	-		1.3	-	dB
		$f = 800 \text{ MHz}; Y_S = Y_{S(opt)}$	-		1.4	-	dB
Xmod	cross-modulation	input level for $k = 1$ %; $f_w = 50$ MHz; $f_{unw} = 60$ MHz	[2]				
		at 0 dB AGC	90	)	-	-	$dB\mu V \\$
		at 10 dB AGC	-		88	-	$dB\mu V$
		at 20 dB AGC	-		94	-	$dB\mu V$
		at 40 dB AGC	10	00	103	-	dBμV

<sup>[1]</sup> For the MOSFET not in use:  $V_{G1-S(A)} = 0 \text{ V}$ ;  $V_{DS(A)} = 0 \text{ V}$ .

<sup>[2]</sup> Measured in Figure 30 test circuit.

#### **Dual N-channel dual gate MOSFET**

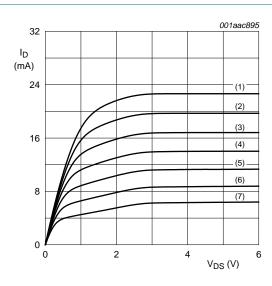
#### 8.2.1 Graphs for amplifier B



- (1)  $V_{G2-S} = 4 \text{ V}$ .
- (2)  $V_{G2-S} = 3.5 \text{ V}.$
- (3)  $V_{G2-S} = 3 \text{ V}.$
- (4)  $V_{G2-S} = 2.5 \text{ V}.$
- (5)  $V_{G2-S} = 2 V$ .
- (6)  $V_{G2-S} = 1.5 \text{ V}.$
- (7)  $V_{G2-S} = 1 \text{ V}.$

 $V_{DS(B)}$  = 5 V;  $V_{G1\text{-}S(A)}$  = 0 V;  $T_{j}$  = 25 °C.

Fig 16. Amplifier B: transfer characteristics; typical values



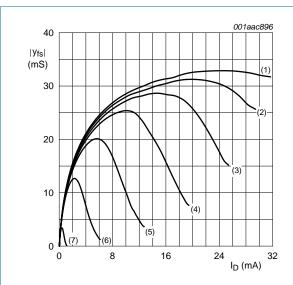
- (1)  $V_{G1-S(B)} = 1.7 \text{ V}.$
- (2)  $V_{G1-S(B)} = 1.6 \text{ V}.$
- (3)  $V_{G1-S(B)} = 1.5 \text{ V}.$
- (4)  $V_{G1-S(B)} = 1.4 \text{ V}.$
- (5)  $V_{G1-S(B)} = 1.3 \text{ V}.$ (6)  $V_{G1-S(B)} = 1.2 \text{ V}.$
- (7)  $V_{G1-S(B)} = 1.1 \text{ V}.$

 $V_{G2-S} = 4 \text{ V}; V_{G1-S(A)} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}.$ 

Fig 17. Amplifier B: output characteristics; typical values

**BF1207 NXP Semiconductors** 

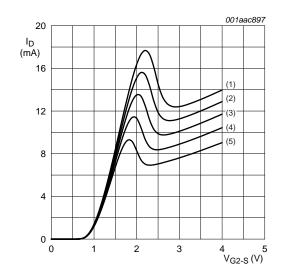
#### **Dual N-channel dual gate MOSFET**



- (1)  $V_{G2-S} = 4 \text{ V}$ .
- (2)  $V_{G2-S} = 3.5 \text{ V}.$
- (3)  $V_{G2-S} = 3 \text{ V}.$
- (4)  $V_{G2-S} = 2.5 \text{ V}.$
- (5)  $V_{G2-S} = 2 V$ .
- (6)  $V_{G2-S} = 1.5 \text{ V}.$
- (7)  $V_{G2-S} = 1 \text{ V}$ .

 $V_{DS(B)} = 5 \text{ V}; V_{G1-S(A)} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}.$ 

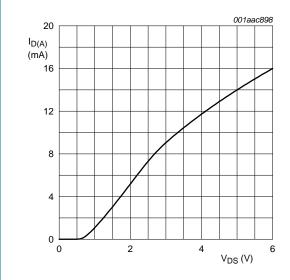
Fig 18. Amplifier B: forward transfer admittance as a



- (1)  $V_{DS} = 5 \text{ V}.$
- (2)  $V_{DS} = 4.5 \text{ V}.$
- (3)  $V_{DS} = 4 V$ .
- (4)  $V_{DS} = 3.5 \text{ V}.$
- (5)  $V_{DS} = 3 V$ .

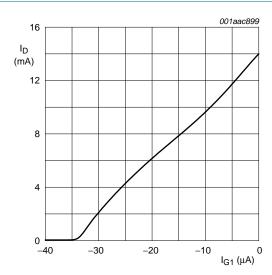
 $V_{G1-S(A)} = 0 \text{ V; } T_j = 25 \text{ }^{\circ}\text{C.}$ 





 $V_{DS(B)}$  = 5 V;  $V_{G1\text{-}S(A)}$  = 0 V;  $T_j$  = 25 °C.

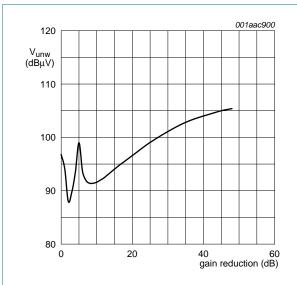
Fig 20. Amplifier B: drain current as a function of drain source voltage; typical values



 $V_{DS(B)} = 5 \text{ V}; V_{G2-S} = 4 \text{ V}; V_{G1-S(A)} = 0 \text{ V}; T_j = 25 \text{ }^{\circ}\text{C}.$ 

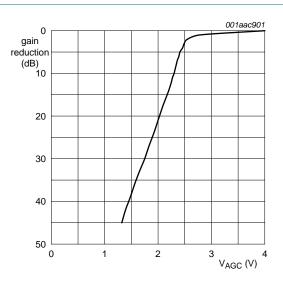
Fig 21. Amplifier B: drain current as a function of gate1 current; typical values

#### **Dual N-channel dual gate MOSFET**



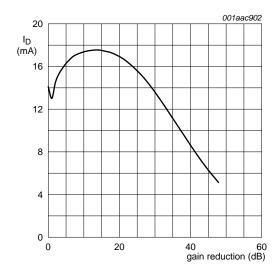
$$\begin{split} &V_{DS(B)}=5~V;~V_{GG}=5~V;~V_{DS(A)}=V_{G1\text{-}S(A)}=0~V;\\ &R_{G1(B)}=150~k\Omega~(connected~to~V_{GG});~f_w=50~MHz;\\ &f_{unw}=60~MHz;~T_{amb}=25~^{\circ}C;~see~Figure~30. \end{split}$$

Fig 22. Amplifier B: unwanted voltage for 1 % cross-modulation as a function of gain reduction; typical values



$$\begin{split} &V_{DS(B)}=5~V;~V_{GG}=5~V;~V_{DS(A)}=V_{G1\text{-}S(A)}=0~V;\\ &R_{G1(B)}=150~k\Omega~(connected~to~V_{GG});~f=50~MHz;\\ &T_{amb}=25~^{\circ}C;~see~\underline{Figure~30}. \end{split}$$

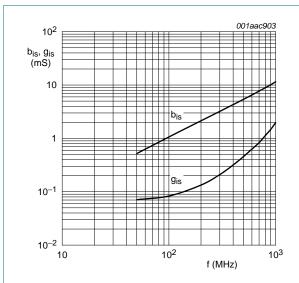
Fig 23. Amplifier B: typical gain reduction as a function of AGC voltage; typical values



 $V_{DS(B)} = 5 \text{ V}; V_{GG} = 5 \text{ V}; V_{DS(A)} = V_{G1\text{-}S(A)} = 0 \text{ V}; R_{G1(B)} = 150 \text{ k}\Omega \text{ (connected to } V_{GG}); f = 50 \text{ MHz}; T_{amb} = 25 \text{ °C}; \text{ see } \underline{\text{Figure 30}}.$ 

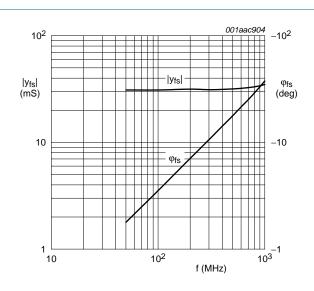
Fig 24. Amplifier B: drain current as a function of gain reduction; typical values

#### **Dual N-channel dual gate MOSFET**



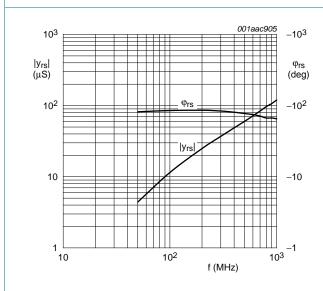
 $V_{DS(B)}=5$  V;  $V_{G2\text{-}S}=4$  V;  $V_{DS(A)}=V_{G1\text{-}S(A)}=0$  V;  $I_{D(B)}=14$  mA.

Fig 25. Amplifier B: input admittance as a function of frequency; typical values



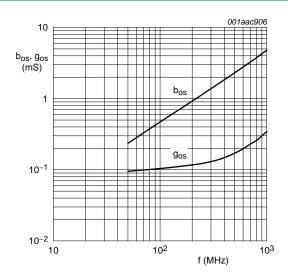
$$\begin{split} V_{DS(B)} = 5 \text{ V; } V_{G2\text{-}S} = 4 \text{ V; } V_{DS(A)} = V_{G1\text{-}S(A)} = 0 \text{ V; } \\ I_{D(B)} = 14 \text{ mA}. \end{split}$$

Fig 26. Amplifier B: forward transfer admittance and phase as a function of frequency; typical values



 $V_{DS(B)}=5$  V;  $V_{G2\text{-}S}=4$  V;  $V_{DS(A)}=V_{G1\text{-}S(A)}=0$  V;  $I_{D(B)}=14$  mA.

Fig 27. Amplifier B: reverse transfer admittance and phase as a function of frequency; typical values



 $V_{DS(B)}$  = 5 V;  $V_{G2\text{-}S}$  = 4 V;  $V_{DS(A)}$  =  $V_{G1\text{-}S(A)}$  = 0 V;  $I_{D(B)}$  = 14 mA.

Fig 28. Amplifier B: output admittance as a function of frequency; typical values

#### **Dual N-channel dual gate MOSFET**

## 8.2.2 Scattering parameters for amplifier B

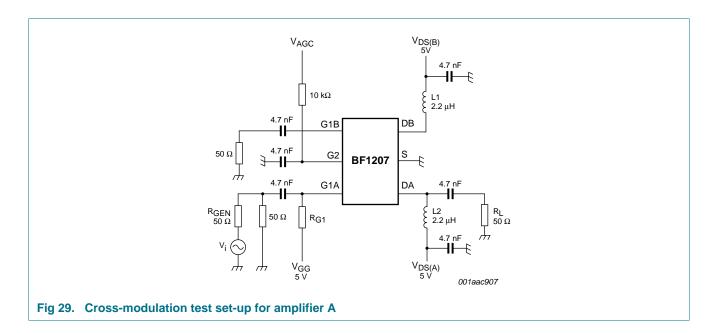
Table 11. Scattering parameters for amplifier B

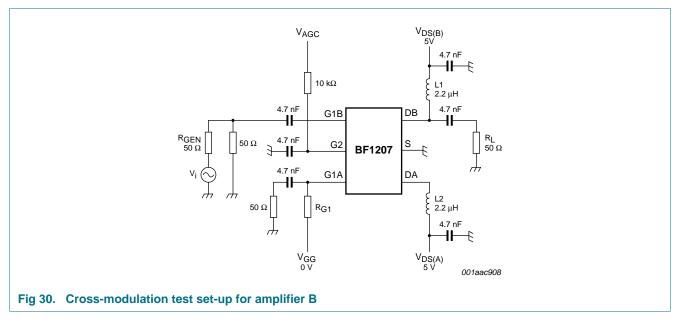
 $V_{DS(B)} = 5 \text{ V}; V_{G2-S} = 4 \text{ V}; I_{D(B)} = 14 \text{ mA}; V_{DS(A)} = 0 \text{ V}; V_{G1-S(A)} = 0 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}; typical values.$ 

f	S <sub>11</sub>		s <sub>21</sub>		s <sub>12</sub>		S <sub>22</sub>	
(MHz)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)
50	0.993	-3.018	3.07	176.04	0.0004	95.97	0.991	-1.39
100	0.992	-6.186	3.07	172.05	0.0011	90.33	0.990	-2.79
200	0.987	-12.43	3.09	164.13	0.0024	85.03	0.988	-5.49
300	0.979	-18.60	3.02	156.28	0.0036	82.94	0.986	-8.21
400	0.969	-24.62	2.99	148.48	0.0046	81.97	0.983	-10.91
500	0.957	-30.72	2.95	140.69	0.0056	81.03	0.980	-13.63
600	0.943	-36.71	2.90	132.87	0.0065	79.77	0.977	-16.40
700	0.927	-42.77	2.86	125.21	0.0074	79.04	0.973	-19.13
800	0.907	-48.91	2.79	117.22	0.0082	79.42	0.969	-21.93
900	0.885	-54.77	2.736	109.29	0.0086	75.47	0.964	-24.85
1000	0.858	-61.01	2.675	101.18	0.0092	73.48	0.958	-27.75

**Dual N-channel dual gate MOSFET** 

## 9. Test information





## **Dual N-channel dual gate MOSFET**

# 10. Package outline

#### Plastic surface-mounted package; 6 leads

**SOT363** 

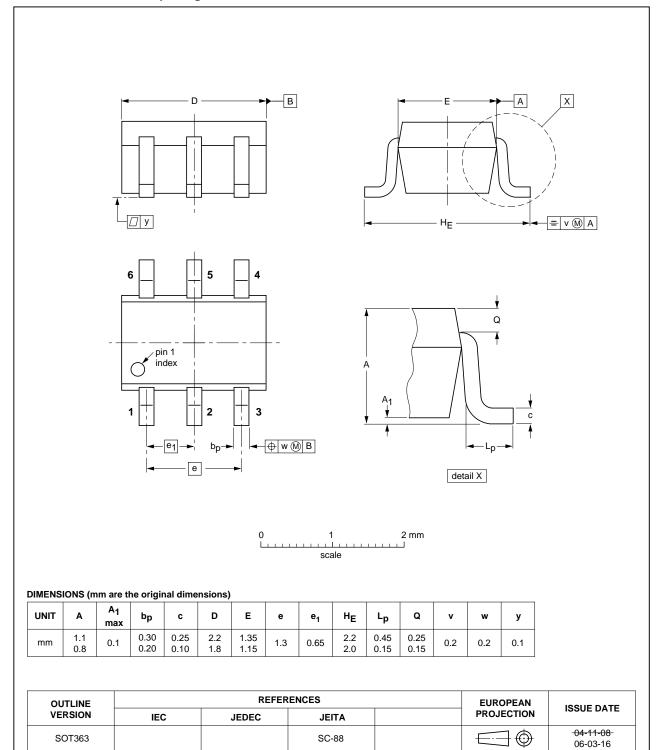


Fig 31. Package outline SOT363

## **Dual N-channel dual gate MOSFET**

# 11. Revision history

#### Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BF1207 v.2	20110907	Product data sheet	-	BF1207 v.1	
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> <li>Legal texts have been adapted to the new company name where appropriate.</li> <li>Package outline drawings have been updated to the latest version.</li> </ul>				
BF1207 v.1 (9397 750 14955)	20050728	Product data sheet	-	-	

#### **Dual N-channel dual gate MOSFET**

## 12. Legal information

#### 12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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BF1207

#### **Dual N-channel dual gate MOSFET**

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#### **Dual N-channel dual gate MOSFET**

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